

<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/773,315	KURODA ET AL.
	Examiner	Art Unit
	Hai L. Nguyen	2816

ORIGINAL			CROSS REFERENCE(S)					
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
327	261	327	279	286				
INTERNATIONAL CLASSIFICATION								
H	0	3	H	11/26	/	/	/	/

  

Hai L. Nguyen (Assistant Examiner) <i>Anne Smith</i> (Legal Instruments Examiner)	11/30/2006 (Date)	TIMOTHY P. CALLAHAN SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800 (Primary Examiner) <i>SPC</i> (Signature)	Total Claims Allowed: 33 O.G. Print Claim(s) 1	O.G. Print Fig. 1 & 3
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<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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5		29	35	65	95	125	155
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16	8	33	38	68	98	128	158
12	9	39		69	99	129	159
13	10	40		70	100	130	160
1	11	41		71	101	131	161
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5	15	45		75	105	135	165
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7	18	48		78	108	138	168
9	19	49		79	109	139	169
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26	26	56		86	116	146	176
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18	29	59		89	119	149	179
19	30	60		90	120	150	180
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